

Hearing Aid Compatibility

FCC 47 CFR section 20.19 Test Report

Dual-Band CDMA Cellular Phone with Bluetooth	
FCC ID:	V65SCP-27H
Model:	SCP-2700

STATEMENT OF CERTIFICATION The data, data evaluation and equipment configuration represented herein are a true and accurate representation of the measurements of the sample's HAC RF emissions characteristics as of the dates and at the times of the test under the conditions herein specified. STATEMENT OF COMPLIANCE This product was tested in accordance with the measurement procedures specified in ANSI C63.19-2006 and has been shown to be capable of compliance with the technical requirements of FCC 47 CFR section 20.19.		
Report No:	KWC-V65-20.19R-1208-R0	
Report Prepared for:	KYOCERA Corporation KYOCERA SANYO Telecom, Inc. 21605 Plummer Street Chatsworth, CA 91311 United States	
Date of Test: December 12 – December 13, 2008		
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1 Introduction

This test report describes the Hearing Aid Compatibility (HAC) measurement of a wireless portable device manufactured by Kyocera Wireless Corp. (KWC). These measurements were performed for compliance with the rules and regulations of the U.S. Federal Communications Commission (FCC). The testing was performed in accordance with ANSI C63.19-2006.

This report covers test and data on:

X	RF Emissions	ANSI C63.19 Clause 4
	T-Coil	ANSI C63.19 Clause 6

2 Equipment Under Test (EUT)

	KYOCEBA Corporation			
	KYOCERA Corporation			
Annelland	KYOCERA SANYO Telecon	n, Inc.		
Applicant:	21605 Plummer Street			
	Chatsworth California	Chatsworth California		
	United States 91311			
Product:	Dual-Band CDMA Cellular P	hone with Bluetooth		
FCC ID:	V65SCP-27H			
Model Number:	SCP-2700			
EUT Serial Number:	2700D307			
Туре:	[X] Prototype, [] Pre-Production, [] Production			
Device Category:	Portable			
RF Exposure Environment:	General Population / Uncontrolled			
Antenna:	Internal Antenna			
Detachable Antenna:	No			
External Input:	Audio/Digital Data			
Quantity:	Quantity production is planned			
Modes:	800 CDMA 1900 CDMA			
Multiple Access Scheme:	CDMA CDMA			
TX Frequency (MHz):	824 – 849 1850 - 1910			
Rated RF Conducted Output Power	24.5 24.5			
(dBm)				

3 Summary of Test Results

ANSI C63.19 (2005)		
Section 4 RF Emissions		
Test	Test Results Overall Category	
E-Field Emissions	M4	M4
H-Field Emissions	M4	1414

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4 Test conditions

4.1 Ambient Conditions

All tests were performed under the following environmental conditions:

Ambient Temperature:	23 ± 2 Degrees C
Tissue simulating liquid temperature:	22 ± 1 Degrees C
Relative Humidity (RH):	0% <rh 80%<="" <="" th=""></rh>
Atmospheric Pressure:	101.3kPa + 10 to –5kPa

4.2 RF characteristics of the test site

All HAC measurements were performed inside a shielded room that provide isolation from external EM fields, with the RF ambient at least 20 dB below the intended measurement limits.

4.3 Test Signal, Frequencies and Output Power

Peak and Average conducted power were measured for each mode for comparison. RC3 SO55 was chosen for worst-case power configuration.

CONFIGURATION	CONDUCTED POWER (dBm)		sm)	
	CDM	A 800	CDMA 1900	
	Ch	383	Ch 600	
	Peak	Average	Peak	Average
SO2, RC1 Full Rate	28.57	24.64	28.44	24.58
SO2, RC3 Full Rate	28.25	24.62	28.19	24.55
SO55, RC1 Full Rate	28.68	24.62	28.51	24.60
SO55, RC3 Full Rate	28.88	24.68	28.59	24.62
TDSO SO32, RC3 (FCH +SCH)	28.37	24.65	28.15	24.56
Full Rate				
TDSO SO32, RC3 (-SCH) Full	28.36	24.64	28.35	24.59
Rate				



During tests, the EUT was put in in-call mode and controlled by a CDMA simulator to generate the required signal and power using the configuration below.

Protocol:	6 (IS-2000)
Radio Configuration:	3
Power Control:	All Up Bits
Service Option:	55
Data Rate:	Full

In all operating modes, the phone was set to rate maximum RF power level and the measurements were performed on low, mid and high channels.

The measurement system measures power drift during HAC testing by comparing E/H-field in the same location at the beginning and at the end of measurement. These records were used to monitor stability of power output during tests. Conducted RF power measurements were also performed before and after each HAC measurements to confirm the output power.

4.4 EUT Operating Conditions

The EUT was tested with the following configurations and conditions, if applicable:

- **X** Fully charged standard as supplied with the handset
- X At ear use position.
- Both retracted and extended antenna positions
- **X** Back-light tested ON and OFF
- x Simultaneous transmission with Bluetooth transmitter ON

5 Description of the test equipment

5.1 Test Equipment Used

Below is a list of the calibrated equipment used for the measurements:

Description	Manufacturer	Model Number	Serial Number	Cal Due Date
Power Meter	Giga-tronics	8541C	1831038	07/15/09
Signal Generator	Hewlett Packard	E4421B	US38440337	07/14/09
Radio Communication Tester	Rohde & Schwarz	CMU200	101328	03/10/09
Data Acq	Speag	DAE4	530	04/15/09
E-field Probe	Speag	ER3DV6	2341	04/17/09
H-field Probe	Speag	H3DV6	6123	08/18/09
Dipole Antenna (835MHz)	Speag	CD835V3	1020	04/26/09
Dipole Antenna (1880MHz)	Speag	CD1880V3	1015	04/26/09
Spectrum Analyzer	Hewlett Packard	8594E	3710A04899	02/27/10

The calibration certificates of E-field and H-field probes are attached in Appendix A.

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5.2 Near Field Measurement System

The measurements were performed with Dasy4 automated near-field scanning system comprised of high precision robot, robot controller, computer, near-field probe, probe alignment sensor, non-conductive phone positioner, Test Arch and software extension. The overall expanded uncertainty (K=2) of the measurement system is $\pm 10.9\%$ and $\pm 14.7\%$ for H-field and E-field resp. The measurement uncertainty budget is given in section 6.

5.3 Isotropic E-Field Probe

Model	 ER3DV6
Construction	 One dipole parallel, two dipoles normal to probe axis Built-in shielding against static charges PEEK enclosure material (resistant to organic solvents, e.g., glycolether)
Calibration	 In air from 100 MHz to 3.0 GHz (absolute accuracy ± 6%; k=2)
Frequency	 100MHz to 6 GHz Linearity: ± 0.2dB (100MHz to 3GHz)
Directivity	 ± 0.2 dB in air (rotation around probe axis) ± 0.4 dB in air (rotation normal to probe axis)
Dynamic Range	 2 V/m to > 1000 V/m Linearity: ± 0.2 dB
Dimensions	 Overall length: 330 mm (Tip: 16 mm) Tip diameter: 8 mm (Body: 12 mm) Distance from probe tip to dipole centers: 2.5 mm
Application	 General near-field measurements up to 6 GHz Field component measurements Fast automatic scanning in phantoms



5.4 Isotropic H-Field Probe

Model	 H3DV6
Construction	 Three concentric loop sensors with 3.8 mm loop diameters Resistively loaded detector diodes for linear response Built-in shielding against static charges PEEK enclosure material (resistant to organic solvents, e.g., glycolether)
Frequency	 200 MHz to 3 GHz (± 6.0%, k=2); Output linearized
Directivity	 ± 0.25 dB (spherical isotropy error)
Dynamic Range	 10 mA/m to 2 A/m at 1 GHz
E-Field Interference	< 10% at 3 GHz (for plane wave)
Dimensions	 Overall length: 330 mm (Tip: 40 mm)
	 Tip diameter: 6 mm (Body: 12 mm)
	 Distance from probe tip to dipole centers: 3 mm
Application	 General magnetic near-field measurements up to 3 GHz
	 Field component measurements
	 Surface current measurements
	 Measurements in air or liquids
	 Low interaction with the measured field

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6 System Validation

The manufacturer calibrates the probes annually. The HAC measurements of the device were done within 24 hours of system accuracy verification, which was done using calibration dipoles. Unmodulated continuous wave of power level of 20dBm was supplied to a dipole antenna placed under Test Arch. The measurement probes are positioned over the illuminated dipole at 10mm distance from the top surface of the dipole element to the calibration reference point of the sensor, defined by the probe manufacturer.

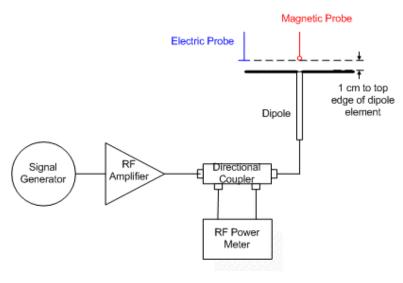


Figure 6 - System Check Setup

The length of the dipole was scanned with both E and H-field probes and the maximum values for each were recorded. The validation results are in the table below and printouts of the validation test are attached in Appendix B. All the measured parameters were within the specification.

Freq. (MHz)	Parameter	Target, SPEAG	Measured	Delta (%)	Limit (%)	Test date
	E dB(V/m)	165.2	153.8	-6.90	± 25	12/12/08
836.49	H dB(A/m)	0.447	0.424	-5.15	± 25	12/12/08
030.49	E dB(V/m)	165.2	166.8	0.97	± 25	12/13/08
	H dB(A/m)	0.447	0.470	5.15	± 25	12/13/08
	E dB(V/m)	134.5	134.5	0.00	± 25	12/12/08
1880	H dB(A/m)	0.461	0.464	0.65	± 25	12/12/08
1000	E dB(V/m)	134.5	142.1	5.65	± 25	12/13/08
	H dB(A/m)	0.461	0.494	7.20	± 25	12/13/08

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7 Description Of The Test Procedure

The device was positioned and setup according to ANSI C63.19-2006.

7.1 Test Positions

The device was placed on a non-conductive phone positioner under the Test Arch.

7.2 RF Emission Measurements Reference and Plane

Figure 7.2 illustrates the references and reference plane that shall be used in the EUT emissions measurement:

- The grid is 5 cm by 5 cm area that is divided into 9 evenly sized blocks or sub-grids.
- The grid is centered on the audio frequency output transducer (speaker) of the EUT.
- The grid is in a reference plane, which is defined as the planar area that contains the highest point in the area of the phone that normally rests against the user's ear. It is parallel to the centerline of the receiver of the EUT and is defined by the points of the receiver-end of the EUT, which, in normal handset use, rest against the ear.
- The measurement plane is parallel to, and 1.0 cm in front of, the reference plane.

	Vertica	I centerline of phone
5 x 5 cm grid		Horizontal centerline of acoustic output
		Measurement plane 1.0 cm Reference plane

Figure 7.2 – Measurement Reference and Plane

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7.3 RF Emissions Measurement Procedures

Figure 7.6 shows the near field emission measurement flowchart:

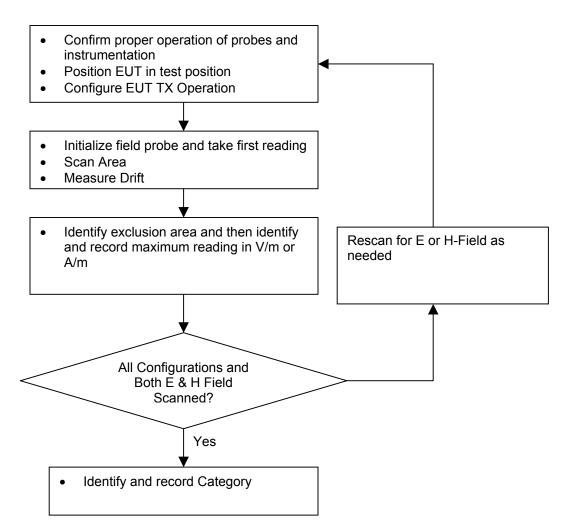


Figure 7.3 - Near field emission measurement flowchart

- 1. The center of the probe was scanning to the edges of the grid. Accordingly the total area covered by the outside edge of the probe was the 5 cm by 5 cm area, increased by half (½) the probe diameter on all sides.
- 2. The nearest point on the probe measurement element(s) was held 1.0 cm from the EUT reference plane.
- 3. The probe element is that portion of the probe that is designed to receive and sense the field being measured.
- 4. The physical body of the probe housing was not used when setting this 1.0 cm distance as this would place the sensing elements at an indeterminate distance from the reference plane.
- 5. The step size of the scan is set to 5 mm or less.
- 6. Up to three blocks were excluded for each field measurement.
 - The center block containing the EUT output was not excluded.
 - A maximum of five blocks were excluded for both E- and H-field measurements for the EUT output being measured. Stated differently, the center sub-grid or block and 3 other blocks were common to both the E- and H-field measurements for a given grid.

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7.4 Probe Modulation Factor (PMF)

7.4.1 Measurement Procedures

A calibration was made of the modulation response of the probe and its instrumentation chain. This calibration was performed with the field probe, attached to its instrumentation. The response of the probe system to a CW field at the frequency of interest is compared to its response to a modulated signal with equal peak amplitude to that of a CW signal. The field level of the test signals shall be more than 10 dB above the ambient level and the noise floor of the instrumentation being used. The ratio of the CW reading to that taken with a modulated reading was applied to the DUT measurements. The measurement procedures are as following:

- 1. Fix the field probe in a set location relative to the dipole antenna, as illustrated in Figure 7.4.
- 2. Setup the wireless device (EUT) with intended signal at the intended measurement frequency.
- 3. Record the reading of the probe measurement system.
- Replace the wireless device with a RF signal generator producing an unmodulated CW signal and set to the wireless device operating frequency.
- 5. Set the peak power of the unmodulated signal to equal that recorded from the wireless device
- 6. Record the reading of the probe measurement system of the unmodulated CW signal.
- 7. The ratio of probe reading (CW) in step 6 to the probe reading (EUT) in step 3 is the modulation factor.

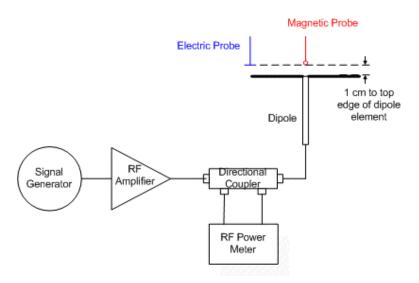


Figure 7.4 - Probe Modulation Setup

The modulation factors obtained by above method shall be applied to readings taken of the actual WD, in order to obtain an accurate peak field reading.

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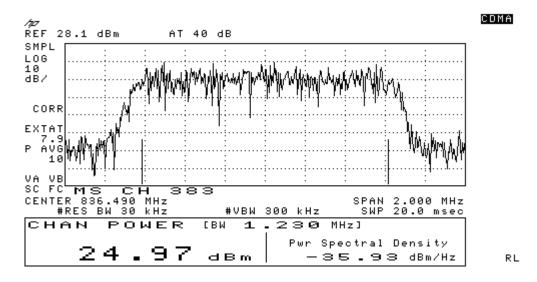
7.4.2 PMF Test Results

		E-Fi	ield		
Frequency (MHz)	Peak Power (dBm)	Protocol	Protocol Reading (V/m)	PMF Ratio	PMF (dB)
	24.98	CW	103.9		
836.49	24.97	CDMA	106.3	0.98	-0.20
	24.95	AM	66.54	1.56	3.9
	23.60	CW	70.76		
1880	23.62	CDMA	73.12	0.97	-0.28
	23.63	AM	46.97	1.51	3.6
		H-F	ield		
Frequency (MHz)	Peak Power (dBm)	Protocol	Protocol Reading (A/m)	PMF Ratio	PMF (dB)
	24.97	CW	0.312		
836.49	24.95	CDMA	0.319	0.98	-0.2
	24.94	AM	0.206	1.51	3.6
	23.82	CW	0.294		
1880	23.81	CDMA	0.305	0.96	-0.3
	23.83	AM	0.189	1.56	3.8

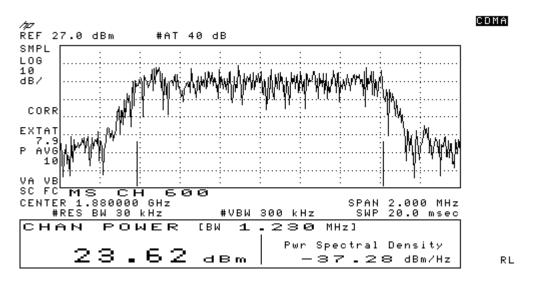
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7.4.3 PMF Peak Power Measurement Plots



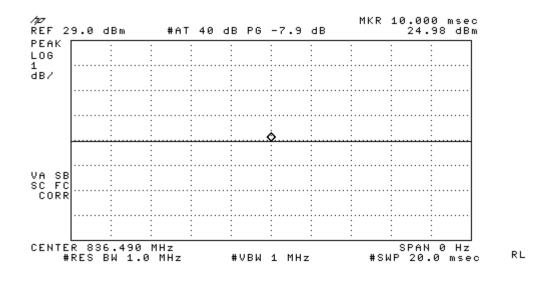
CDMA-800



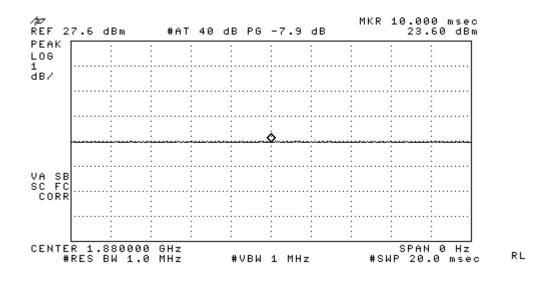
CDMA-1900

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CW -800

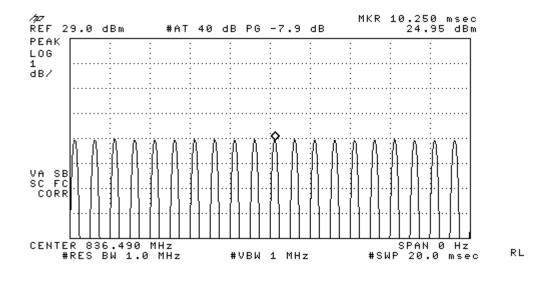


CW -1900

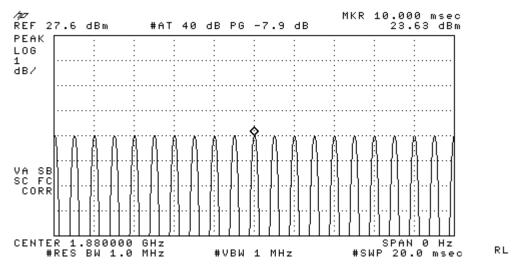
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80% AM -800



80% AM -1900

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8 Emission Data Extraction and Post processing

At the end of the measurements, the DASY4 system automatically evaluates the slot-averaged results, exclusion of the three highest sub-grid, application of the AWF factor per ANSI-C63.19 requirements.

The following AWF factors were used for the standard transmission protocols:

Standard	Technology	AWF
TIA/EIA/IS-2000	CDMA	0
TIA/EIA-136	TDMA (50 Hz)	0
J-STD-007	GSM (217)	-5
T1/T1P1/3GPP	UMTS (WCDMA)	0
iDEN [™]	TDMA(22 and 11 Hz)	0

Table 7.5a - Articulation Weighting Factor (AWF)

All DASY4 measurements are in RMS values. The Dasy4 system incorporates the crest factor of the signal in the computation of the RMS values. Although the software also has the capability to estimate the peak field by applying a square root of the crest factor value to the readings, the probe modulation factor was applied manually instead per ANSI C63.19 in the measurement tables in this report using equation:

Peak Field = (DASY4 reading) x PMF

where DASY4 reading = measurement from DASY4 in V/m or A/m PMF = Probe Modulation Factor in linear unit



9 Measurement Uncertainty

Table 9 shows the uncertainty budget for HAC free field assessment according to ANSI C63.19-2006. The budget is valid for the frequency range 800 MHz - 3 GHz and represents a worst-case analysis. For specific tests and configurations, the uncertainty could be smaller.

Uncertainty Description	Uncert. Value (± %)	Prob. Dist.	Div.	C _i (E)	C _i (H)	Stand. Uncert (E) (±%)	Stand. Uncert (H) (±%)
Measurement system							
Probe calibration	5.1	Ν	1	1	1	5.1	5.1
Axial isotropy of the probe	4.7	R	√3	1	1	2.7	2.7
Sensor displacement	16.5	R	√3	1	0.145	9.5	1.4
Boundary effects	2.4	R	√3	1	1	1.4	1.4
Probe linearity	4.7	R	√3	1	1	2.7	2.7
Scaling to Peak Envelope Power	2.0	R	√3	1	1	1.2	1.2
System Detection limit	1.0	R	√3	1	1	0.6	0.6
Readout electronics	0.3	N	1	1	1	0.3	0.3
Response time	0.8	R	√3	1	1	0.5	0.5
Integration time	2.6	R	√3	1	1	1.5	1.5
RF ambient conditions	3.0	R	√3	1	1	1.7	1.7
RF Reflections	12	R	√3	1	1	6.9	6.9
Probe Positioner	1.2	R	√3	1	0.67	0.7	0.5
Probe positioning	4.7	R	√3	1	0.67	2.7	1.8
Extrap. and integration	1.0	R	√3	1	1	0.6	0.6
Test Sample Related							
Device positioning vertical	4.7	R	√3	1	0.67	2.7	1.8
Device Positioning Lateral	1.0	R	√3	1	1	0.6	0.6
Device Holder and Phantom	2.4	R	√3	1	1	1.4	1.4
Power drift	5.0	R	√3	1	1	2.9	2.9
Phantom and Setup Related							
Phantom thickness	2.4	R	√3	1	0.67	1.4	0.9
		ombined				14.7	10.9
	ded Standa					29.4	21.8
Exte	ended Stan	dard Und	certainty	/ on Fiel	d (k=2):	14.7	10.9

N: Normal

R: Rectangular

Table 9 - Worst-Case uncertainty budget for HAC free field assessment



10 RF Emissions Tests

10.1 Emission Limits

Table 10.1 shows the M-rating criteria from ANSCI C63.19. All digital transmission modes in all frequency bands contained in a HAC phone must meet M3 or M4 levels.

Near		Wireless Device	RF Parameters	;					
Field		[AWF	⁻ = 0]						
Catagory	E-Field E	missions	H-Field E	missions					
Category	dB(V/m) Peak	V/m Peak	dB(A/m) Peak	A/m Peak					
Freq < 960 MHz									
M1	56.0 to 61.0	631.0 to 1122.0	5.6 to 10.6	1.91 to 3.39					
M2	51.0 to 56.0	354.8 to 631.0	0.6 to 5.6	1.07 to 1.91					
M3	46.0 to 51.0	199.5 to 354.8	-4.4 to 0.6	0.60 to 1.07					
M4	< 46.0	< 199.5	< -4.4	< 0.60					
		Freq > 960 MH	Z						
M1	46.0 to 51.0	199.5 to 354.8	-4.4 to 0.6	0.60 to 1.07					
M2	41.0 to 46.0	112.2 to 199.5	-9.4 to -4.4	0.34 to 0.60					
M3	36.0 to 41.0	63.1 to 112.2	-14.4 to -9.4	0.19 to 0.34					
M4	< 36.0	< 63.1	< -14.4	< 0.19					

Table 10.1 - RF Emission Limits

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10.2 CDMA 800 Test Results

	CDMA 800 E-Field												
Configuration:	At ear position				Ant	tenna	Interna	l					
Ch.	Back LightBatteryBTPower before TestPower after TestDasy4 Reading		PMF	Peak Field	Categor y								
#				dBm	dBm	V/m		V/m	М				
1013	ON	Standard	OFF	24.43	24.47	90.00	1.00	90.00	4				
383	ON	Standard	OFF	24.29	24.32	116.20	1.00	116.20	4				
777	ON	Standard	OFF	24.12	24.18	99.30	1.00	99.30	4				
383	OFF	Standard	OFF	24.29	24.32	118.10	1.00	118.10	4				
383 (Bluetooth)	OFF	Standard	ON	24.29	24.32	115.10	1.00	115.10	4				

Data plots are shown in Appendix C

	CDMA 800 H-Field												
Configuration:		At ear positi	on		Ant	enna	Interna	l					
Ch.	Back light	Battery	BT	Power before Test	Power Dasy4 after Reading Test		PMF	Peak Field	Categor y				
#				dBm	dBm	A/m			М				
1013	ON	Standard	OFF	24.43	24.47	0.123	1.00	0.123	4				
383	ON	Standard	OFF	24.29	24.32	0.152	1.00	0.152	4				
777	ON	Standard	OFF	24.12	24.18	0.125	1.00	0.125	4				
383	OFF	Standard	OFF	24.29	24.32	0.151	1.00	0.151	4				
383 (Bluetooth)	OFF	Standard	ON	24.29	24.32	0.160	1.00	0.160	4				
383(360°)	OFF	Standard	ON	24.29	24.32	0.157	1.00	0.157	4				

Data plots are shown in Appendix C

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10.3 CDMA 1900 Test Results

			C	DMA 190	0 E-Field				
Configuration:		At ear position			Ant	enna	Internal		
Ch.	Back light	Battery	BT	Power before Test	Power Dasy4 after Reading Test		PMF	Peak Field	Categor y
#				dBm	dBm	V/m		V/m	М
25	ON	Standard	OFF	24.60	24.66	45.50	1.00	45.50	4
600	ON	Standard	OFF	24.76	24.80	51.50	1.00	51.50	4
1175	ON	Standard	OFF	24.81	24.84	52.80	1.00	52.80	4
600	OFF	Standard	OFF	24.76	24.80	51.50	1.00	51.50	4
600 (Bluetooth)	ON	Standard	ON	24.76	24.80	50.00	1.00	50.00	4

Data plots are shown in Appendix C

_			С	DMA 190	0 H-Field				
Configuration:		At ear posi	tion		Ant	enna	Internal		
Ch.	Back light	Battery	вт	Power before Test	Power after Test	Dasy4 Reading	PMF	Peak Field	Categor y
#				dBm	dBm	A/m		A/m	М
25	ON	Standard	OFF	24.60	24.66	0.181	1.00	0.181	4
600	ON	Standard	OFF	24.76	24.80	0.180	1.00	0.180	4
1175	ON	Standard	OFF	24.81	24.84	0.157	1.00	0.157	4
600	OFF	Standard	OFF	24.76	24.80	0.178	1.00	0.178	4
600 (Bluetooth)	ON	Standard	ON	24.76	24.80	0.114	1.00	0.114	4
600 (360 [°])	ON	Standard	OFF	24.76	24.80	0.118	1.00	0.118	4

Data plots are shown in Appendix C

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10.4 Worst-Case Configuration Evaluation

10.4.1 Peak Reading 360° Probe Rotation at Azimuth axis

The probe was rotated 360° in the worst-case configuration. The rotation was performed at the location of maximum field strength in the included blocks.

	CDMA 800 E-Field											
Configuration: At ear position Antenna: Internal												
Ch.	Backlight	Battery	Battery Conducted Peak Field PMF Peak Field Power Power Peak Field PMF Peak Field PMF			Category						
#			dBm	V/m		V/m	М					
383	OFF	Standard	24.29	115	1.0	115	4					

	CDMA 1900 E-Field											
Configu	ration: At ear position Antenna: Internal											
Ch.	Backlight	Battery	y Conducted Peak Field PMF Peak Field C Power			Category						
#			dBm	V/m		V/m	М					
600	ON	Standard	24.76	52.30	1.0	52.30	4					

Data plots are shown in Appendix C

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11 Appendix A: Probe Calibration Certification

Accreditation Service (SAS) Accreditation No.: SCS 108 The Swiss Accreditation Service is one of the signatories to the EA. Accreditation Service is one of the signatories to the EA. Autilizateral Agreement for the recognition of calibration certificates Certificate No: ER3-2341_Ar CALIBRATION CERTIFICATE Certificate No: ER3-2341_Ar Object ER3DV6 - SN:2341 Calibration procedure(s) QA CAL-02 v5 Calibration procedure(s) QA CAL-02 v5 Calibration procedure(s) QA CAL-02 v5 Calibration on procedure for E-field probes optimized for close near fevaluations in air Calibration date: April 17, 2008 Candition of the calibrated item In Tolerance This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (1) The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certification equipment used (M&TE critical for calibration) Calibration Equipment used (M&TE critical for calibration) Priver meter E44198 ID # Cal Date (Certificate No.) Schedule Calibration Apr-08	
CALIBRATION CERTIFICATE Object ER3DV6 - SN:2341 Calibration procedure(s) QA CAL-02 v5 Calibration procedure for E-field probes optimized for close near fevaluations in air Calibration date: April 17, 2008 Condition of the calibrated item In Tolerance This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (3 The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate near of the certificate in Equipment used (M&TE critical for calibration) Primary Standards ID # Cal Date (Certificate No.) Schedule Calibratio Calibration S Apr/09	
Object ER3DV6 + SN:2341 Calibration procedure(s) QA CAL-02 v5 Calibration procedure for E-field probes optimized for close near f evaluations in air Calibration date: April 17, 2008 Condition of the calibrated item In Tolerance This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate All calibration Equipment used (M&TE critical for calibration) Primary Standards ID # Cal Date (Certificate No.) Schedule Calibration Calibration Since No.) Primary Standards ID # Cal Date (Certificate No.) Schedule Calibration Calibration Since No.)	field
Calibration procedure(s) QA CAL-02 v5 Calibration procedure for E-field probes optimized for close near fevaluations in air Calibration date: April 17, 2008 Calibration of the calibrated item In Tolerance This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (for measurements (for measurements (for measurements (for measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate for calibration Equipment used (M&TE critical for calibration) Primary Standards ID # Cal Date (Certificate No.) Schedule Ca Power meter E4419B GB41293874 1-Apr-06 (No. 217-00786) Apr-09	1eic
Calibration procedure for E-field probes optimized for close near fievaluations in air Calibration date: April: 17, 2008 Condition of the calibrated item In Tolerance This calibration cartificate documents the traceability to national standards, which realize the physical units of measurements (1) The measurements and the uncertainties with confidence probability are given on the following pages and are part of the cartificate loculated in the desed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Primary Standards ID # Cal Date (Certificate No.) Schedule Calibration Power meter E4419B GB41293874 1-Apr-08 (No. 217-00786) Apr-09	field.
Condition of the calibrated item In Tolerance Interview and the uncertainties with confidence probability are given on the following pages and are part of the cartificate documents the traceability to national standards, which realize the physical units of measurements (3 The measurements and the uncertainties with confidence probability are given on the following pages and are part of the cartificate for calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Primary Standards ID # Cal Date (Certificate No.) Scheduled Cal Power mater E4419B GB41293874 1-Apr-06 (No. 217-00766) Apr-09	
This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (3 The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certifications have been conducted in the desed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.	A DOMESTIC STREET
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	alibration
Power sensor E4412A MY41495277 1-Apr-06: (No. 217-00768) Apr-09	
Power sensor E4412A MY41498087 1-Apr-08 (No. 217-00788) Apr-09	
Reference 3 dB Attenuator SN: S5054 (3c) 8-Aug-07 (No. 217-00719) Aug-08	
Reference 20 dB Attenuator SN: S5086 (20b) 31-Mar-O8 (No. 217-00787) Apr-09	
Reference 30 dB Attenuator SN: 55129 (30b) 8-Aug-07 (No. 217-00720) Aug-08	
Reference Probe ES3DV2 SN: 3013 2-Jan-06 (No. ES3-3013_Jan-08) Jan-09 DAE4 SN: 654 20-Apr-07 (No. DAE4-654_Apr07) Apr-08	
Secondary Standards ID # Check Date (in house) Scheduled Ch	
RF generator HP 8648C US3642U01700 4-Aug-99 (in house check Oct-07) In house check	hark
	ck: Oct-09
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Zeughausstrasse 43, 8004 Zuri	ch, Switzerland		Servizio svizzero di taratura
Accredited by the Swiss Accredit The Swiss Accreditation Servi	ce is one of the signator	ies to the EA	n No.: SCS 108
Multilateral Agreement for the	-		a: H3-6123 Aug08
Client Kyocera USA			C 10-0125_Augus
CALIBRATION	CERTIFICAT	E	
Object	H3DV6 - SN:61	23	
Calibration procedure(s)	CA CAL-03.v5 Calibration proc evaluations in a	edure for H-field probes optimized	l for close near field
Calibration date:	August 18, 200	8	
Condition of the calibrated item	In Tolerance		
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12 Appendix B: System Validation Plots

(See attachment)

13 Appendix C: Test Results/Plots

(See attachment)

14 Appendix D: Photo Test Setup

(see attachment)

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